

Am8120

Octal D-Type Flip-Flop with Clear, Clock Enable and Three-State Control

DISTINCTIVE CHARACTERISTICS

- Buffered common clock enable input
- Buffered common asynchronous clear input
- Three-state outputs
- 8-bit, high-speed parallel register with positive edge-triggered, D-type flip-flops

GENERAL DESCRIPTION

The Am8120 is an 8-bit register built using advanced Low-Power Schottky technology. The register consists of eight D-type flip-flops with a buffered common clock, a buffered common clock enable, a buffered asynchronous clear input, and three-state outputs.

When the clear input is LOW, the internal flip-flops of the register are reset to logic 0 (LOW), independent of all other inputs. When the clear input is HIGH, the register operates in the normal fashion.

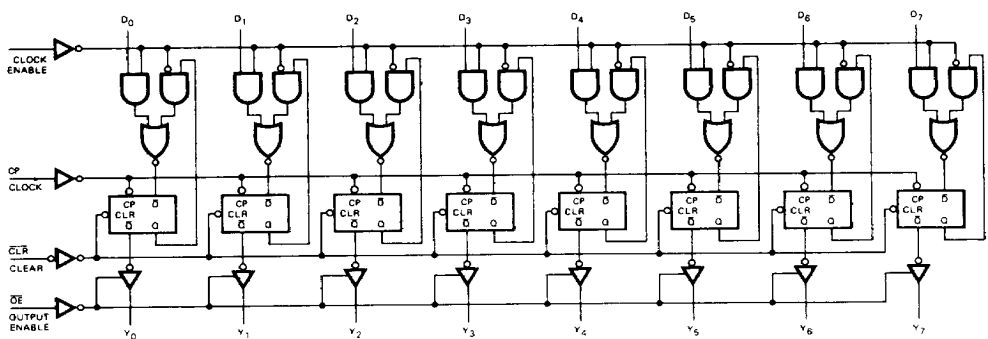
When the three-state output enable (\overline{OE}) input is LOW, the Y outputs are enabled and appear as normal TTL outputs.

When the output enable (\overline{OE}) input is HIGH, the Y outputs are in the high impedance (three-state) condition. This does not affect the internal state of the flip-flop Q output.

The clock enable input (\overline{E}) is used to selectively load data into the register. When the \overline{E} input is HIGH, the register will retain its current data. When the \overline{E} is LOW, new data is entered into the register on the LOW-to-HIGH transition of the clock input.

This device is packaged in a slim 24-pin package (0.3 inch row spacing).

BLOCK DIAGRAM



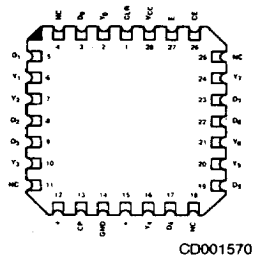
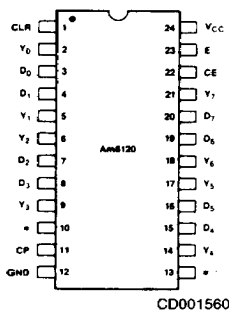
BD001280

RELATED PRODUCTS

Part No.	Description
Am25S18	Quad D Register
Am2920	Octal D Type Flip-flop
Am2954/5	Octal D Registers

CONNECTION DIAGRAM Top View

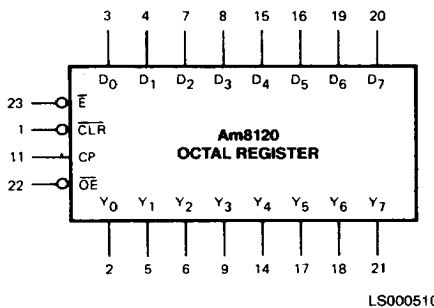
Leadless Chip Carrier L-28-1



Note: Pin 1 is marked for orientation

*Reserved – do not use.

LOGIC SYMBOL



ORDERING INFORMATION

AMD products are available in several packages and operating ranges. The order number is formed by a combination of the following: Device number, speed option (if applicable), package type, operating range and screening option (if desired).

Am8120

D

C

B

Screening Option
Blank – Standard processing
B – Burn-in

Temperature (See Operating Range)
C – Commercial (0°C to +70°C)
M – Military (–55°C to +125°C)

Package

D – 24-pin CERDIP (D-24-SLIM)
F – 24-pin ceramic flatpak (F-24-1)
L – 28-pin leadless chip carrier (L-28-1)
P – 24-pin plastic DIP (P-24-1)
X – Dice

Device type
Octal D-type Flip-flop

Valid Combinations

Am8120	DC, DM FM LC, LM PC XC, XM
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Valid Combinations

Consult the AMD sales office in your area to determine if a device is currently available in the combination you wish.

PIN DESCRIPTION

Pin No.	Name	I/O	Description
	D _i	I	The D flip-flop data inputs.
1	CLR	I	When the clear input is LOW, the Q _i outputs are LOW, regardless of the other inputs. When the clear input is HIGH, data can be entered into the register.
11	CP	I	Clock Pulse for the Register; enters data into the register on the LOW-to-HIGH transition.
	Y _i	O	The register three-state outputs.
23	\overline{E}	I	Clock Enable. When the clock enable is LOW, data on the D _i input is transferred to the Q _i output on the LOW-to-HIGH clock transition. When the clock enable is HIGH, the Q _i outputs do not change state, regardless of the data or clock input transitions.
22	\overline{OE}	I	Output Control. When the \overline{OE} input is HIGH, the Y _i outputs are in the high impedance state. When the \overline{OE} input is LOW, the TRUE register data is present at the Y _i outputs.

Function Table

Inputs					Internal	Outputs	Function
\overline{OE}	CLR	\overline{E}	D _i	CP	Q _i	Y _i	
H	X	X	X	X	X	Z	Hi-Z
H	L	X	X	X	L	Z	Clear
L	L	X	X	X	L	L	
H	H	H	X	X	NC	Z	Hold
L	H	H	X	X	NC	NC	
H	H	L	L	↑	L	Z	Load
H	H	L	H	↑	H	Z	
L	H	L	L	↑	L	L	
L	H	L	H	↑	H	H	

H = HIGH NC = No Change
 L = LOW ↑ = LOW-to-HIGH Transition
 X = Don't Care Z = High Impedance

ABSOLUTE MAXIMUM RATINGS

Storage Temperature -65°C to +150°C
 Temperature (Ambient) Under Bias -55°C to +125°C
 Supply Voltage to Ground Potential
 Continuous -0.5V to +7.0V
 DC Voltage Applied to Outputs For
 High Output State -0.5V to +V_{CC} max
 DC Input Voltage -0.5V to +7.0V
 DC Output Current, Into Outputs 30mA
 DC Input Current -30mA to +5.0mA

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Temperature 0°C to +70°C
 Supply Voltage +4.75V to +5.25V

Military (M) Devices

Temperature -55°C to +125°C
 Supply Voltage +4.5V to +5.5V

Operating ranges define those limits over which the functionality of the device is guaranteed.

DC CHARACTERISTICS over operating range unless otherwise specified

Parameters	Description	Test Conditions (Note 1)		Min	Typ (Note 2)	Max	Units
V _{OH}	Output HIGH Voltage	V _{CC} = MIN V _{IN} = V _{IH} or V _{IL}	MIL, I _{OH} = -1.0mA COM'L, I _{OH} = -2.6mA	2.4 2.4	3.4 3.4		Volts
V _{OL}	Output LOW Voltage	V _{CC} = MIN V _{IN} = V _{IH} or V _{IL}	I _{OL} = 4.0mA I _{OL} = 8.0mA			0.4 0.45	Volts
V _{IH}	Input HIGH Level	Guaranteed input logical HIGH voltage for all inputs		2.0			Volts
V _{IL}	Input LOW Level	Guaranteed input logical LOW voltage for all inputs				0.7 0.8	Volts
V _I	Input Clamp Voltage	V _{CC} = MIN, I _{IN} = -18mA				-1.5	Volts
I _{IL}	Input LOW Current	V _{CC} = MAX, V _{IN} = 0.4V				-0.36	mA
I _{IH}	Input HIGH Current	V _{CC} = MAX, V _{IN} = 2.7V				20	μA
I _I	Input HIGH Current	V _{CC} = MAX, V _{IN} = 7.0V				0.1	mA
I _O	Off-State (High-Impedance) Output Current	V _{CC} = MAX	V _O = 0.4V			-20	μA
			V _O = 2.4V			20	
I _{SC}	Output Short Circuit Current (Note 3)	V _{CC} = MAX		-15		-85	mA
I _{CC}	Power Supply Current (Note 4)	V _{CC} = MAX			24	37	mA

- Notes: 1. For conditions shown as MIN or MAX, use the appropriate value specified under Operating Range for the applicable device type.
 2. Typical limits are at V_{CC} = 5.0V, 25°C ambient and maximum loading.
 3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.
 4. All outputs open, E = GND, D_i inputs = CLR = OE = 4.5V. Apply momentary ground, then 4.5V to clock input.

SWITCHING CHARACTERISTICS ($T_A = +25^\circ\text{C}$, $V_{CC} = 5.0\text{V}$)

Parameters	Description	Test Conditions	Min	Typ	Max	Units
t_{PLH}	Clock to Y_i (\overline{OE} LOW)	$C_L = 15\text{pF}$ $R_L = 2.0\text{k}\Omega$		18	27	ns
t_{PHL}	Clear to Y			24	36	ns
t_{PHL}	Clear to Y			22	35	ns
t_s	Data (D_i)		10	3		ns
t_h	Data (D_i)		10	3		ns
t_s	Enable (\overline{E})		15	10		ns
	Active		20	12		ns
	Inactive		0	0		ns
t_h	Enable (\overline{E})		11	7		ns
t_s	Clear Recovery (In-Active) to Clock		20	14		ns
t_{pw}	Clock		25	13		ns
	HIGH		20	13		ns
t_{pw}	Clear		20	13		ns
t_{ZH}	\overline{OE} to Y_i			9	13	ns
t_{ZL}	\overline{OE} to Y_i			14	21	ns
t_{HZ}	\overline{OE} to Y_i	$C_L = 5.0\text{pF}$ $R_L = 2.0\text{k}\Omega$		20	30	ns
t_{LZ}	\overline{OE} to Y_i			24	36	ns
f_{max}	Maximum Clock Frequency (Note 1)			40		MHz

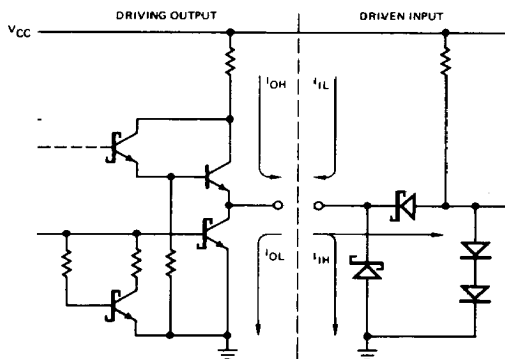
Note 1. Per industry convention, f_{max} is the worst case value of the maximum device operating frequency with no constraints on t_r , t_f , pulse width or duty cycle.

SWITCHING CHARACTERISTICS over operating range unless otherwise specified*

Parameters	Description	Test Conditions	COMMERCIAL		MILITARY		Units
			Min	Max	Min	Max	
t_{PLH}	Clock to Y_i (\overline{OE} LOW)	$C_L = 50\text{pF}$ $R_L = 2.0\text{k}\Omega$		33		39	ns
t_{PHL}	Clear to Y			45		54	ns
t_{PHL}	Clear to Y			43		51	ns
t_s	Data (D_i)		12		15		ns
t_h	Data (D_i)		12		15		ns
t_s	Enable (\overline{E})		17		20		ns
	Active		20		23		ns
	Inactive		0		0		ns
t_h	Enable (\overline{E})		13		15		ns
t_s	Clear Recovery (In-Active) to Clock		25		30		ns
t_{pw}	Clock		30		35		ns
	HIGH		22		25		ns
t_{pw}	Clear			19		25	ns
t_{ZH}	\overline{OE} to Y_i			30		39	ns
t_{ZL}	\overline{OE} to Y_i			35		40	ns
t_{HZ}	\overline{OE} to Y_i	$C_L = 5.0\text{pF}$ $R_L = 2.0\text{k}\Omega$		39		42	ns
t_{LZ}	\overline{OE} to Y_i			39		42	ns
f_{max}	Maximum Clock Frequency (Note 1)		25		20		MHz

*AC performance over the operating temperature range is guaranteed by testing defined in Group A, Subgroup 9.

LOW-POWER SCHOTTKY INPUT/OUTPUT CURRENT INTERFACE CONDITIONS



IC000090

Note: Actual current flow direction shown.